## DATA SHEET



# MOS FIELD EFFECT TRANSISTOR $\mu$ PA1705

### SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

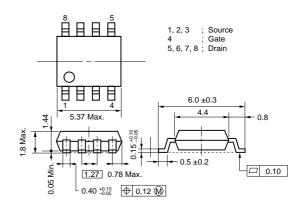
#### DESCRIPTION

This product is N-Channel MOS Field Effect Transistor designed for DC/DC Converters and power management application of notebook computers.

#### FEATURES

- Super low on-state resistance  $R_{DS(on)1} = 19.0 \text{ m}\Omega \text{ TYP}. (V_{GS} = 10 \text{ V}, \text{ ID} = 4.0 \text{ A})$  $R_{DS(on)2} = 30.0 \text{ m}\Omega \text{ TYP}. (V_{GS} = 4.5 \text{ V}, \text{ ID} = 4.0 \text{ A})$
- Low Ciss : Ciss = 750 pF TYP.
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

#### PACKAGE DRAWING (Unit : mm)

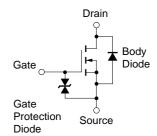


#### **ORDERING INFORMATION**

PART NUMBER	PACKAGE
μΡΑ1705G	Power SOP8

#### ABSOLUTE MAXIMUM RATINGS (TA = 25 °C, All terminals are connected.)

Drain to Source Voltage (Vgs = 0)	VDSS	30	V
Gate to Source Voltage (VDS = 0)	Vgss	±25	V
Drain Current (DC)	D(DC)	±8	А
Drain Current (Pulse) <sup>Note1</sup>	D(pulse)	±50	А
Total Power Dissipation (T <sub>A</sub> = 25 °C) $^{Note2}$	Р⊤	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to + 150	°C



EQUIVALENT CIRCUIT

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1 %

- 2. Mounted on ceramic substrate of 1200 mm<sup>2</sup> x 1.7 mm
- **Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage Exceeding the rated voltage may be applied to this device.

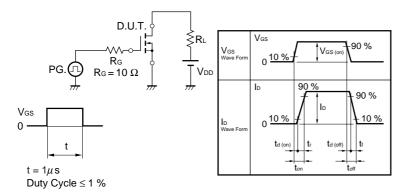
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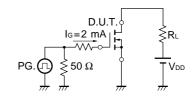
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = 10 \text{ V}, \text{ Id} = 4.0 \text{ A}$		19	27	mΩ
	RDS(on)2	Vgs = 4.5 V, Id = 4.0 A		30	40	mΩ
Gate to Source Cut-off Voltage	VGS(off)	Vbs = 10 V, lb = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance	<b>y</b> fs	$V_{DS} = 10 V, I_{D} = 4.0 A$	4.0	8.4		S
Drain Leakage Current	loss	$V_{DS} = 30 V$ , $V_{GS} = 0 V$			10	μA
Gate to Source Leakage Current	lgss	$V_{GS} = \pm 25 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Input Capacitance	Ciss	Vds = 10 V		750		pF
Output Capacitance	Coss	Vgs = 0 V		350		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		160		pF
Turn-on Delay Time	td(on)	ID = 4.0 A		19		ns
Rise Time	tr	$V_{GS(on)} = 10 V$		107		ns
Turn-off Delay Time	td(off)	Vdd = 15 V		50		ns
Fall Time	tr	Rg = 10 Ω		32		ns
Total Gate Charge	QG	ID = 8.0 A		19		nC
Gate to Source Charge	QGS	V <sub>DD</sub> = 24 V		2.4		nC
Gate to Drain Charge	Qgd	Vgs = 10 V		6.3		nC
Body Diode Forward Voltage	VF(S-D)	IF = 8.0 A, VGS = 0 V		0.8		V
Reverse Recovery Time	trr	If = 8.0 A, Vgs = 0 V		33		ns
Reverse Recovery Charge	Qrr	di/dt = 100A/µs		22		nC

ELECTRICAL CHARACTERISTICS (TA = 25 °C, All terminals are connected.)

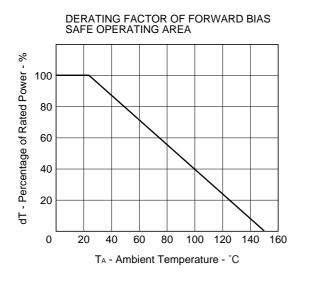
#### **TEST CIRCUIT 1 SWITCHING TIME**



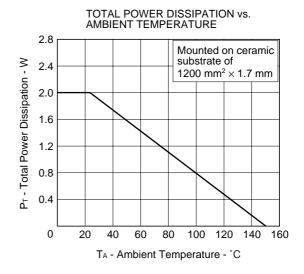
#### **TEST CIRCUIT 2 GATE CHARGE**



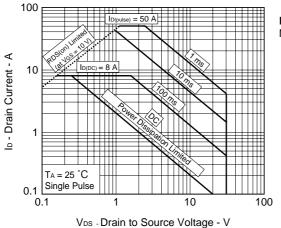
#### TYPICAL CHARACTERISTICS (TA = 25 °C, All terminals are connected.)



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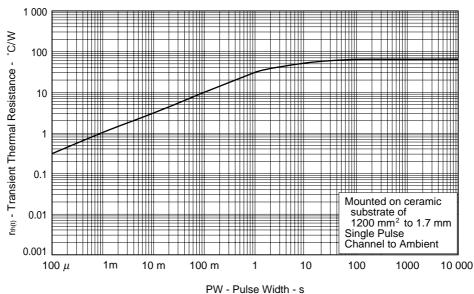


FORWARD BIAS SAFE OPERATING AREA



 $\mbox{Remark}$  Mounted on ceramic substrate of 2000  $\mbox{mm}^2 \times 1.7 \mbox{ mm}$ 





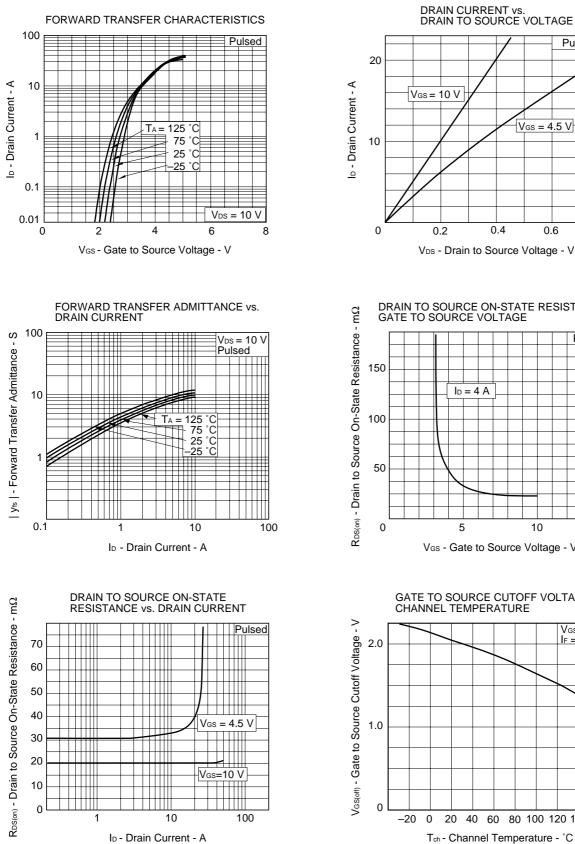
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Pulsed

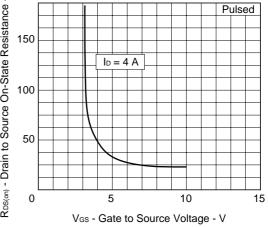
Vgs = 4.5 V

0.6

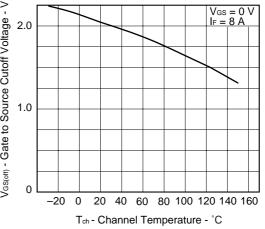
0.8

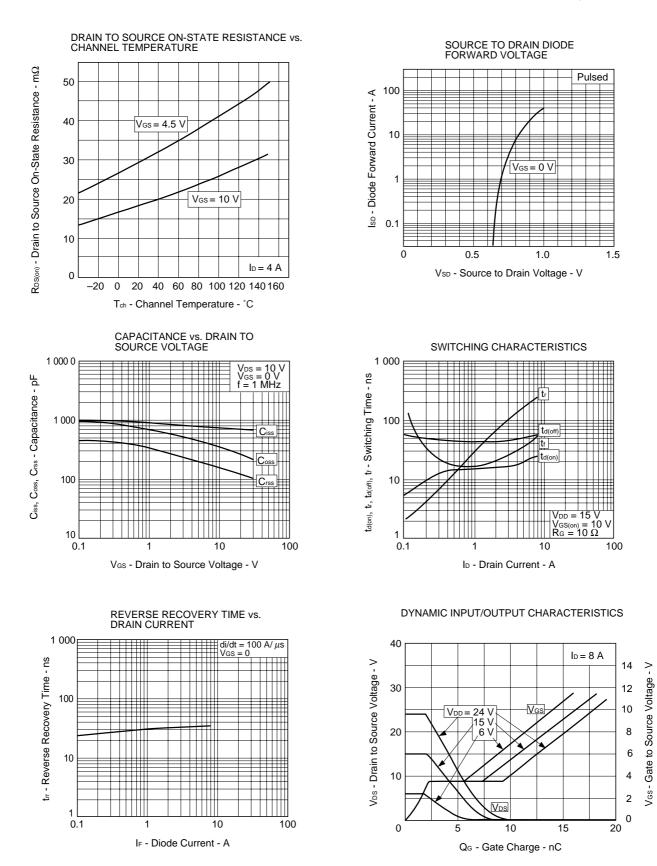


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



GATE TO SOURCE CUTOFF VOLTAGE vs. CHANNEL TEMPERATURE





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